

Features

- High Peak Output Current
- Low Output Impedance
- •Low Quiescent Supply Current
- Low Propagation Delay
- High Capacitive Load Drive Capability
- Wide Operating Voltage Range

Applications

- •RF MOSFET Driver
- Class D and E RF Generators
- •Multi-MHz Switch Mode Supplies
- Pulse Transformer Driver
- Pulse Laser Diode Driver
- Pulse Generator

Description

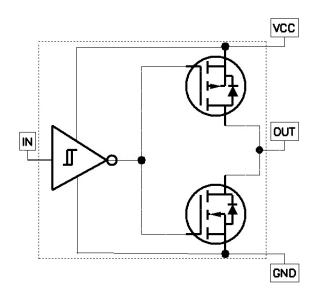
The IXRFD630 is a CMOS highspeed, high-current gate driver specifically designed to drive MOSFETs in Class D and E HF RF applications as well as other applications requiring ultrafast rise and fall times or short mini-



mum pulse widths. The IXRFD630 can source and sink 30 A of peak current while producing voltage rise and fall times of less than 4 ns and minimum pulse widths of 8 ns. The input of the driver is compatible with TTL or CMOS and is fully immune to latch up over the entire operating range. Designed with small internal delays, cross conduction or current shoot-through is virtually eliminated. The features and wide safety margin in operating voltage and power make the IXRFD630 unmatched in performance and value.

The surface mount IXRFD630 is packaged in a lowinductance RF package incorporating advanced layout techniques to minimize stray lead inductances for optimum switching performance.

Fig. 1- Block Diagram and Truth Table



IN	OUT
0	0
1	1



Absolute Maximum Ratings			
Parameter	Value		
Supply Voltage V _{CC}	30V		
Input Voltage Level V _{IN}	-5V to V_{CC} + 0.3V		
All Other Pins	-0.3V to V_{CC} +0.3V		
Power Dissipation $T_{A \text{ (AMBIENT)}} \le 25C$ $T_{C \text{ (CASE)}} \le 25C$	2W 100W		
Storage Temperature	-40°C to 150°C		
Soldering Lead Temperature (10 seconds maximum)	300°C		

Parameter	Value
Maximum Junction Temperature	150° C
Operating Temperature Range	-40° C to 85° C
Thermal Impedance (Junction to Case) $R_{\Theta JC}$	0.25° C/W

Note: Operating the device outside of the "Absolute Maximum Ratings" may cause permanent damage. Typical values indicate conditions for which the device is intended to be functional but do not guarantee specific performance limits. The guaranteed specifications apply only for the test conditions listed. Exposure to absolute maximum conditions for extended periods may impact device reliability.

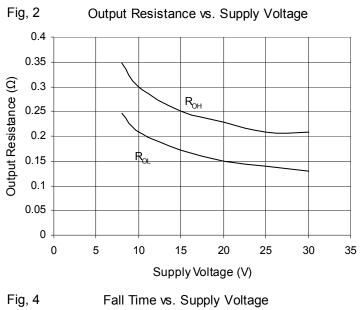
Electrical Characteristics

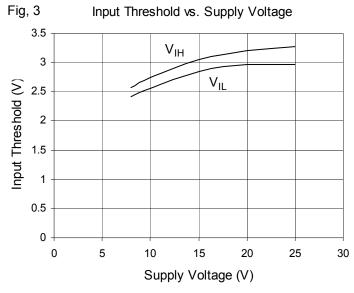
Unless otherwise noted, T_A = 25° C, 8V < V_{CC} < 30V. All voltage measurements with respect to GND. IXRFD630 configured as described in *Test Conditions*.

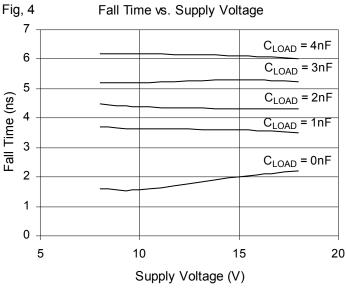
Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
VIH	High input voltage	Vcc = 15V for typical value	3.5	3		V
VIL	Low input voltage	Vcc = 15V for typical value		2.8	0.8	V
VHYS	Input hysteresis			0.23		V
Vin	Input voltage range		-5		Vcc + 0.3	V
lin	Input current	0V≤ V _{IN} ≤V _{CC}	-10		10	μA
Vон	High output voltage		Vcc - 0.025			V
Vol	Low output voltage				0.025	V
Rон	High output resistance	Vcc = 15V Iout = 100mA		0.25		Ω
Rol	Low output resistance	Vcc = 15V lout = 100mA		0.17		Ω
I PEAK	Peak output current	Vcc = 15V		28		Α
IDC	Continuous output current			2.5		Α
t R	Rise time	Vcc=15V C∟=1nF C∟=2nF		4 5		ns ns
t⊧	Fall time	Vcc=15V CL=1nF CL=2nF		4 5.5		ns ns
tondly	ON propagation delay	Vcc =15V CL=2nF		24		ns
t offdly	OFF propagation delay	Vcc =15V CL=2nF		22		ns
PWmin	Minimum pulse width	FWHM Vcc =15V CL=1nF		8		ns
Vcc	Power supply voltage	Recommended	8	15	18	V
Icc	Power supply current	$V_{CC} = 15V, V_{IN} = 0V$ $V_{CC} = 15V, V_{IN} = 3.5V$ $V_{CC} = 15V, V_{IN} = V_{CC}$		0 1 0	1 3 5	mA mA mA

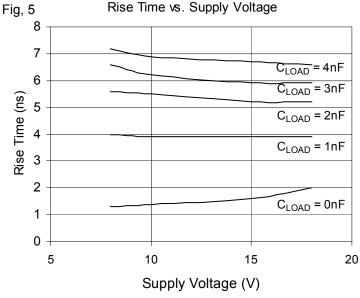
CAUTION: These devices are sensitive to electrostatic discharge; follow proper ESD procedures when handling and assembling.

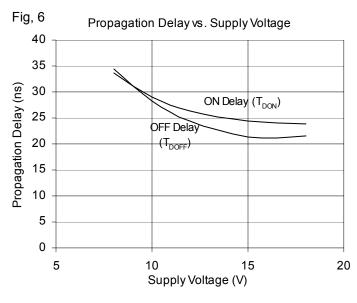


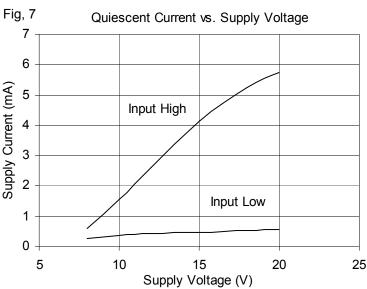




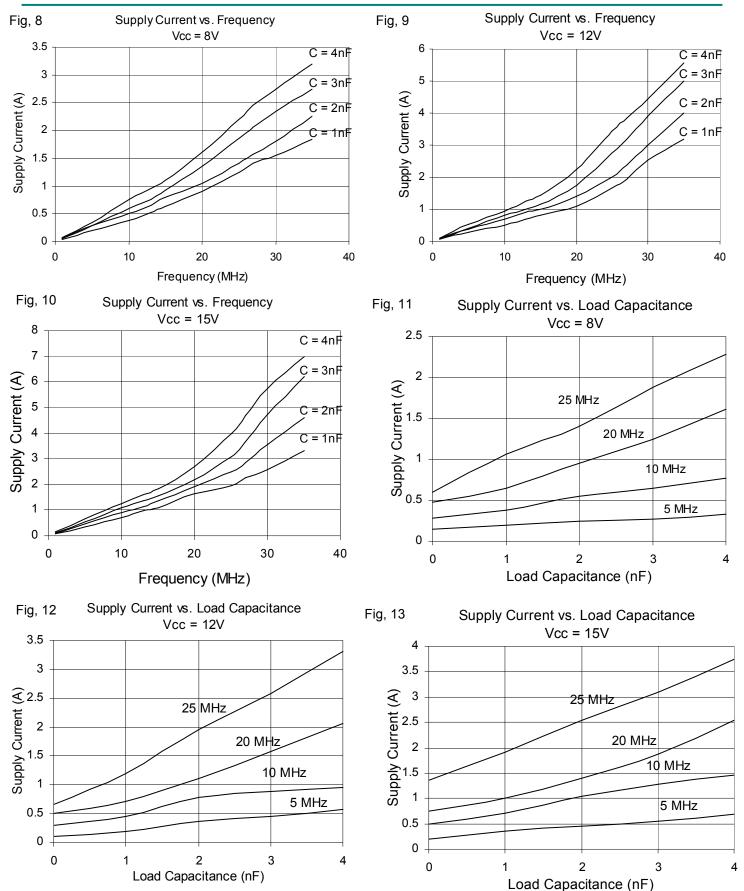




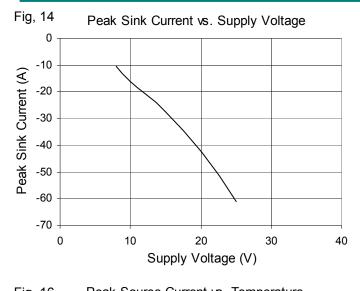


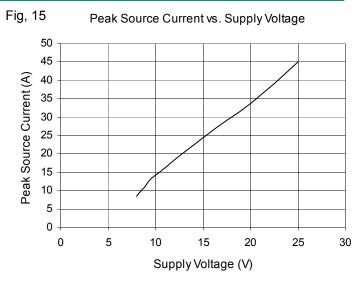


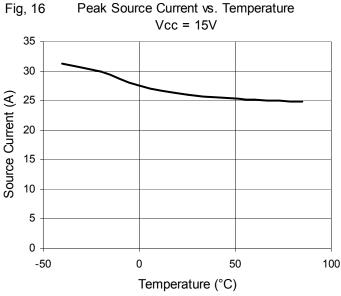


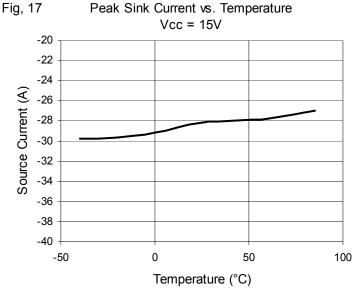


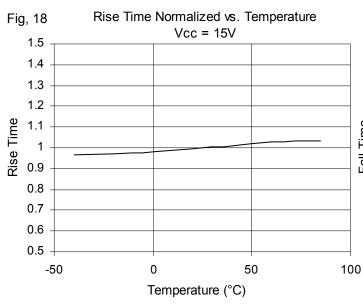












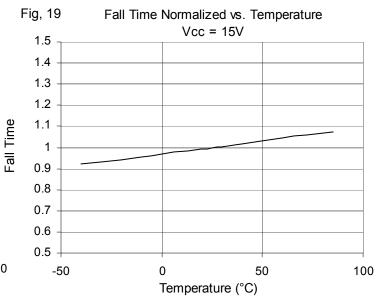




Fig. 20 Pin Description

Symbol	Function	Description
V _{CC}	Supply Voltage	Positive power supply voltage input. These leads provide power to the entire device.
IN	Input	Input signal-TTL or CMOS compatible.
OUT	Output	Device Output. For application purposes, this lead is connected directly to the Gate of a MOSFET
GND	Power Ground	System ground leads. Internally connected to all circuitry, these leads provide ground reference for the entire device and should be connected to a low noise analog ground plane for optimum performance.

Fig. 21 Test Circuit Diagram

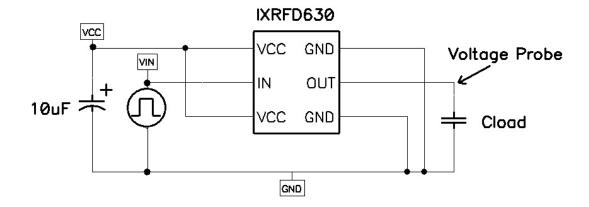
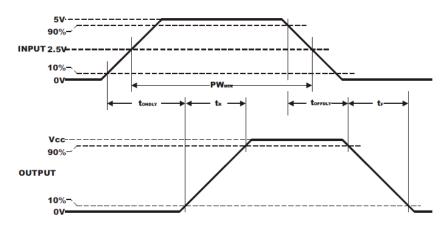
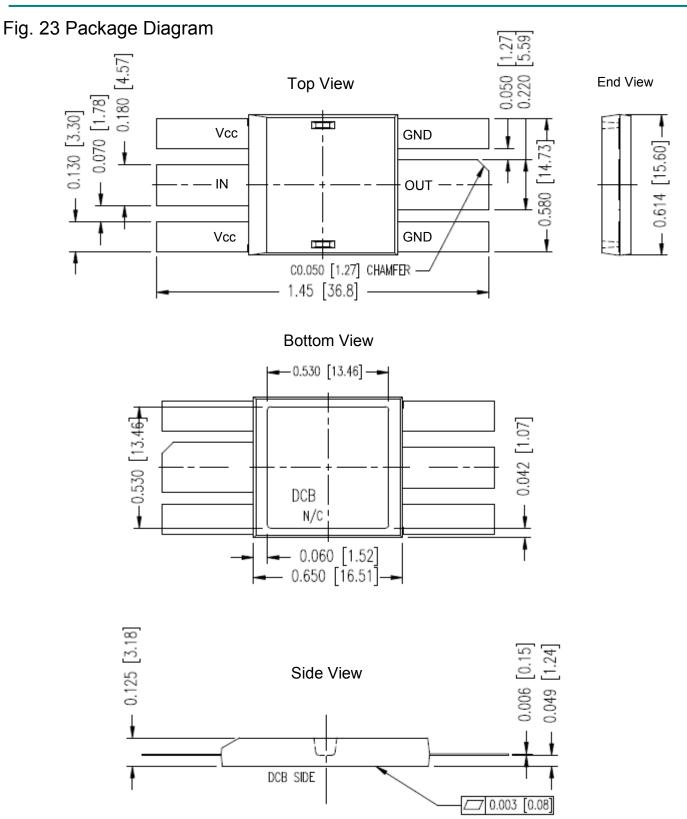


Fig. 22 Timing Diagram







DCB – Direct Copper Bond under Nickel plate on an Aluminum Nitride substrate and is electrically isolated from any pin.



Applications Information

Introduction

Circuits capable of very high switching speeds and high frequency operation require close attention to several important issues. Key elements include circuit loop inductance, Vcc bypassing, and grounding.

Circuit Loop Inductance

The Vcc to Vcc Ground current path defines the loop that generates the inductive term. This loop must be kept as short as possible. The output lead must be no further than 0.375 inches (9.5 mm) from the gate of the MOSFET. Furthermore, the output ground leads must provide a balanced symmetric coplanar ground return for optimum operation.

Vcc Bypassing

In order to turn a MOSFET on properly, the IXRFD630 must be able to draw up to 30 A of current from the Vcc power supply in 2-6 ns (depending upon the input capacitance of the MOSFET being driven). Good performance requires very low impedance between the driver and the power supply. The most common method of achieving this low impedance is to bypass the power supply at the driver with a capacitance value much larger than the load capacitance. Usually, this is achieved by placing two or three different types of bypassing capacitors, with complementary impedance curves, very close to the driver itself. (These capacitors should be carefully selected for low inductance, low resistance, and high pulse current service.) Care should be taken to keep the lengths of the leads between these bypass capacitors and the IXRFD630 to an absolute minimum.

The bypassing should be comprised of several values of MLC (Multi-Layer Ceramic) capacitors symmetrically placed on either side of the IC. Recommended values are 0.01uF and 0.47uF for bypass and at least two 4.7uF tantalums for bulk storage.

Grounding

In order for the design to turn the load off properly, the IXRFD630 must be able to drain 30 A of current into an adequate grounding system. There are two paths for returning current that need to be considered: Path one is between the IXRFD630 and its load, and path two is between the IXRFD630 and its power supply. Both of these paths should be as low in resistance and inductance as possible, and thus as short as practical.

Output Lead Inductance

Of equal importance to supply bypassing and grounding are issues related to the output lead inductance. Every effort should be made to keep the leads between the driver and its load as short and wide as possible, and treated as coplanar transmission lines. In configurations where the optimum configuration of circuit layout and bypassing cannot be used, a series resistance of a few ohms in the gate lead may be necessary to dampen ringing.

Heat Sinking

For high power operation, the bottom side metalized substrate should be placed in compression against an appropriate heat sink. The substrate is metalized for improved heat dissipation, and is not electrically connected to the device or to ground. See the technical note "DE-Series MOS-FET and IC Mounting Instructions" on the IXYS Colorado website at www.ixyscolorado.com for detailed mounting instructions.

